

Search Notes

Application/Control No.

10/739,229

Examiner

David Nhu

Applicant(s)/Patent under
Reexamination

CHO, BYOUNG HEE

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
438	663	2/28/2005	DN
↓	643	↓	↓
	653		
	659		
	590		
	591		
	770		
	775		
↓	769	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEARCHED IN EAST	2/28/2005	DN